Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,850	SHAN ET AL.	
Examiner	Art Unit	
Jean W. Désir	2622	

	SEARCHED						
Class	Class Subclass		Examiner				
348	663	-9/7/OX	6				
	667						
	669						
	670						
	666						
	699						
	700,7	1)					
	968						
			_				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			l		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	9/7/04	6		
		·		